



EMC TEST REPORT

Issued: July 27, 2009

Name and Address of the Client:	Micro Emission Ltd. Ishikawa Create Lab, 2-13 Asahidai, Nomi-shi, Ishikawa-ken 923-1211, Japan
Test Item:	Ultra Compact Elemental Analyzer
Identification:	MH-5000
Serial No.:	MH50000013
Sample No.:	1
Sample Receipt Date:	May 11, 2009 July 15, 2009
Test Specification:	EN 61326-1:2006 EN 55011:2007 + A2:2007 (Group 1 Class A) EN 61000-4-2:1995 + A1:1998 + A2:2001 EN 61000-4-3:2006 + A1:2008 EN 61000-4-4:2004 EN 61000-4-5:2006 EN 61000-4-6:2007 EN 61000-4-8:1993 + A1:2001 EN 61000-4-11:2004 EN 61000-3-2:2006 EN 61000-3-3:1995 + A1:2001 + A2:2005
Date of Testing:	May 14, 20 and 21, 2009 July 17 and 21, 2009
Test Result:	PASS

Tested by:	<u>J. Takashiba</u>	(J. Takashiba, EMC Engineer)
	<u>H. Naka</u>	(H. Naka, EMC Engineer)
Reviewed by:	<u>Y. Kawahara</u>	(Y. Kawahara, EMC Manager)

Other Aspects:

Abbreviations: PASS = passed
FAIL = failed
N/A = not applicable

Notes:

This report should not be reproduced except in full, without the written approval of Cosmos Corporation.
The results in this report apply only to the sample tested.